N-Channel Power MOSFET 600 V, 3.6 Ω

Features

- Low ON Resistance
- Low Gate Charge
- ESD Diode-Protected Gate
- 100% Avalanche Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant



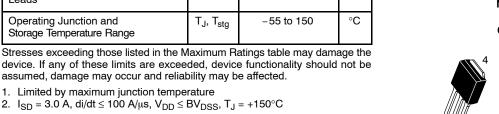
ON Semiconductor®

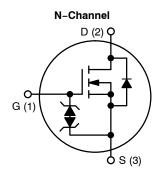
www.onsemi.com

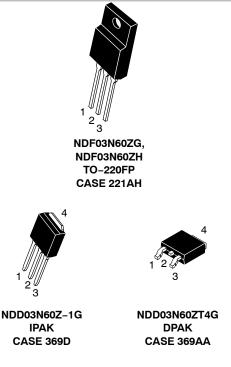
V _{DSS}	R _{DS(on)} (MAX) @ 1.2 A
600 V	3.6 Ω

Rating	Symbol	NDF	NDD	Unit
Drain-to-Source Voltage	V _{DSS}	600		V
Continuous Drain Current $R_{\theta JC}$	۱ _D	3.1 2.6 (Note 1)		A
Continuous Drain Current $R_{\theta JC}$ T_A = 100°C	۱ _D	2.9 (Note 1)	1.65	A
Pulsed Drain Current, $V_{GS} \mathbin{@} 10 \ V$	I _{DM}	12	10	А
Power Dissipation $R_{\theta JC}$	PD	27	61	W
Gate-to-Source Voltage	V _{GS}	±30		V
Single Pulse Avalanche Energy, $I_D = 3.0 A$	E _{AS}	100		mJ
ESD (HBM) (JESD 22-A114)	V _{esd}	3000		V
RMS Isolation Voltage (t = 0.3 sec., R.H. \leq 30%, T_A = 25°C) (Figure 17)	V _{ISO}	4500		V
Peak Diode Recovery (Note 2)	dv/dt	4.5		V/ns
Continuous Source Current (Body Diode)	۱ _S	3.0		A
Maximum Temperature for Soldering Leads	ΤL	T _L 260		°C
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to 150		°C

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)







MARKING AND ORDERING INFORMATION

See detailed ordering and shipping information on page 7 of this data sheet.

THERMAL RESISTANCE

Parameter			Value	Unit
Junction-to-Case (Drain)	NDF03N60Z NDD03N60Z	$R_{\theta JC}$	4.7 2.0	°C/W
Junction-to-Ambient Steady State	(Note 3) NDF03N60Z (Note 4) NDD03N60Z (Note 3) NDD03N60Z-1	$R_{ heta JA}$	51 40 80	

3. Insertion mounted

4. Surface mounted on FR4 board using 1" sq. pad size, (Cu area = 1.127 in sq [2 oz] including traces).

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Test Conditions		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	$V_{GS} = 0 V, I_D = 1 mA$		BV _{DSS}	600			V
Breakdown Voltage Temperature Co- efficient	Reference to 25°C, I _D = 1 mA		$\Delta BV_{DSS}/\Delta T_{J}$		0.6		V/°C
Drain-to-Source Leakage Current		25°C	I _{DSS}			1	μΑ
	$V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$	$0 V, V_{GS} = 0 V$ 150°C				50	
Gate-to-Source Forward Leakage	V _{GS} = ±20 V		I _{GSS}			±10	μΑ
ON CHARACTERISTICS (Note 5)							
Static Drain-to-Source On-Resistance	V _{GS} = 10 V, I _D = 1.2 A		R _{DS(on)}		3.3	3.6	Ω
Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 50 μA		V _{GS(th)}	3.0	3.9	4.5	V
Forward Transconductance	V _{DS} = 15 V, I _D = 1.5 A		9 FS		2.0		S
DYNAMIC CHARACTERISTICS							
Input Capacitance (Note 6)	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz		C _{iss}	248	312	372	pF
Output Capacitance (Note 6)			C _{oss}	30	39	50	
Reverse Transfer Capacitance (Note 6)			C _{rss}	4	8	12	
Total Gate Charge (Note 6)			Qg	6	12	18	nC
Gate-to-Source Charge (Note 6)			Q _{gs}	1.5	2.5	4	
Gate-to-Drain ("Miller") Charge (Note 6)	V_{DD} = 300 V, I_{D} = 3.0 A, V_{GS} = 10 V		Q _{gd}	3	6.1	9	
Plateau Voltage			V _{GP}		6.4		V
Gate Resistance			Rg		6.0		Ω
RESISTIVE SWITCHING CHARACTER	STICS				•		•
Turn-On Delay Time	V_{DD} = 300 V, I_D = 3.0 A, V_{GS} = 10 V, R_G = 5 Ω		t _{d(on)}		9		ns
Rise Time			t _r		8		
Turn-Off Delay Time			t _{d(off)}		16		-
Fall Time			t _f		10		
SOURCE-DRAIN DIODE CHARACTER	ISTICS (T _C = 25°C unless otherw	vise note	ed)		-	-	-
Diode Forward Voltage	I _S = 3.0 A, V _{GS} = 0 V		V _{SD}			1.6	V
Reverse Recovery Time	V _{GS} = 0 V, V _{DD} = 30 V		t _{rr}		265		ns
	$v_{GS} = v v, v_{DD} = 3v v$						

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

 $\begin{array}{l} V_{GS} = 0 \ V, \ V_{DD} = 30 \ V \\ I_S = 3.0 \ A, \ di/dt = 100 \ A/\mu s \end{array}$

Q_{rr}

μC

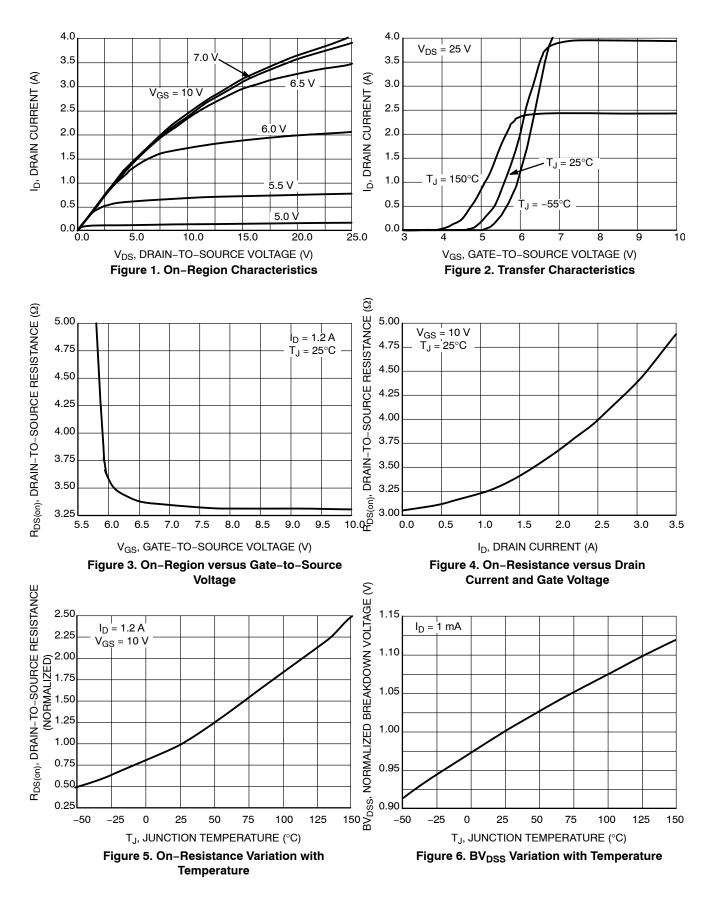
0.9

5. Pulse Width \leq 380 µs, Duty Cycle \leq 2%.

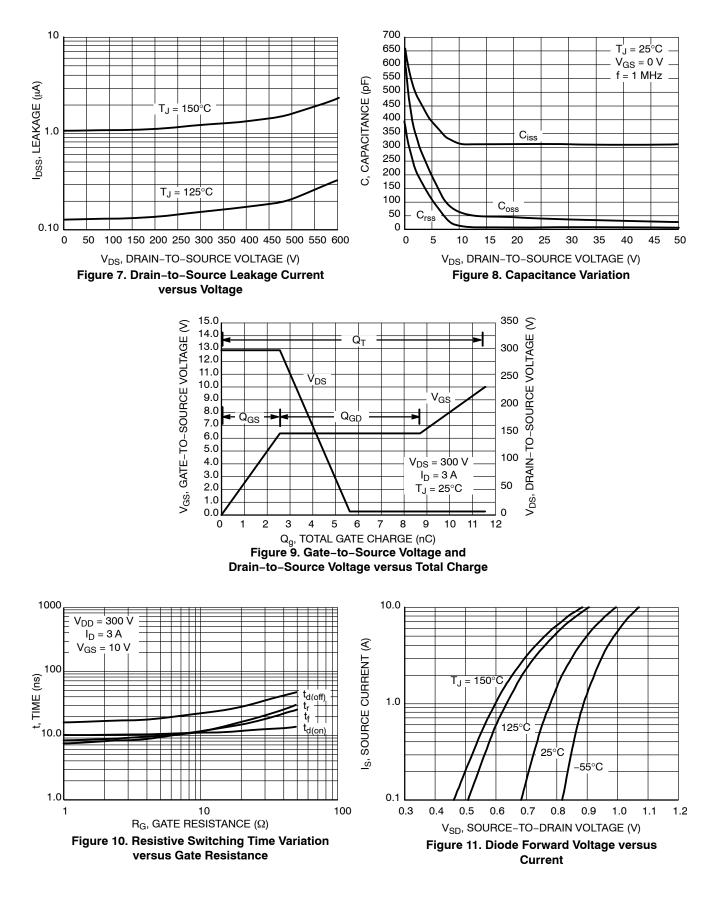
6. Guaranteed by design.

Reverse Recovery Charge

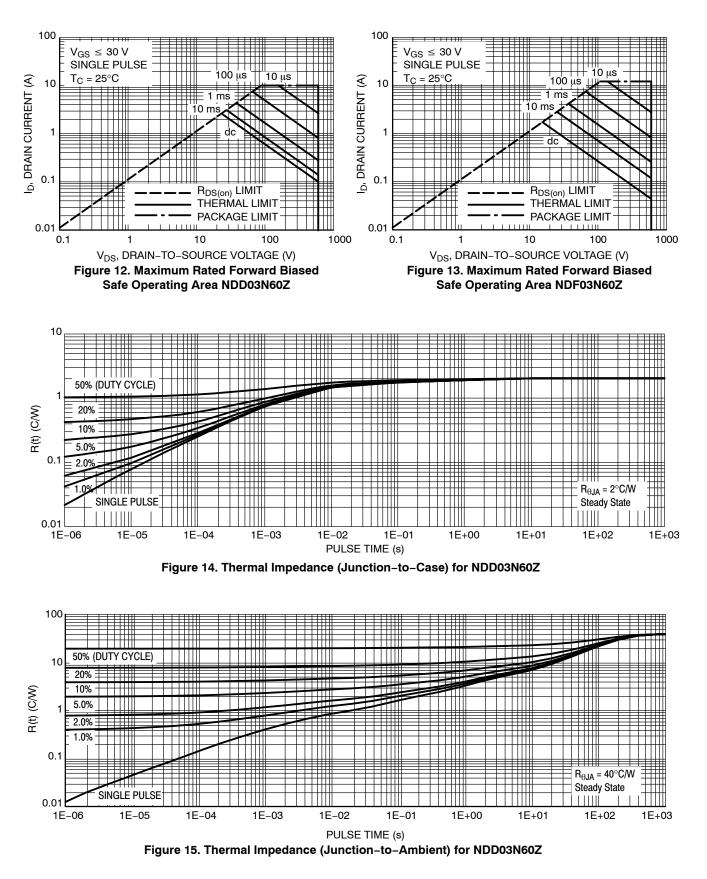
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



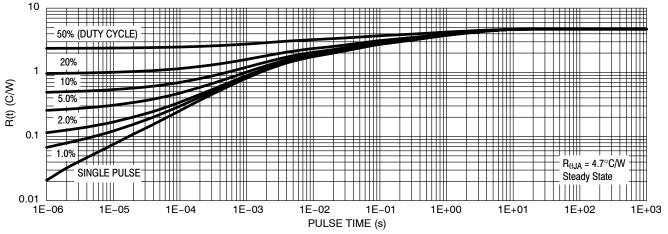


Figure 16. Thermal Impedance (Junction-to-Case) for NDF03N60Z

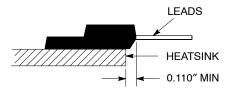


Figure 17. Isolation Test Diagram

Measurement made between leads and heatsink with all leads shorted together.

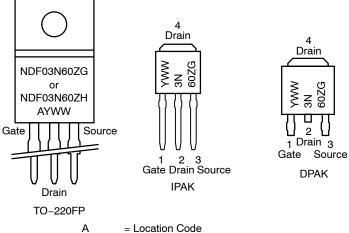
*For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ORDERING INFORMATION

Order Number	Package	Shipping [†]
NDF03N60ZG	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail
NDF03N60ZH	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail
NDD03N60Z-1G	IPAK (Pb-Free, Halogen-Free)	75 Units / Rail
NDD03N60ZT4G	DPAK (Pb-Free, Halogen-Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MARKING DIAGRAMS



= Location Code

Y = Year

- WW = Work Week
- = Pb-Free, Halogen-Free Package G, H

PACKAGE DIMENSIONS

TO-220 FULLPACK, 3-LEAD CASE 221AH

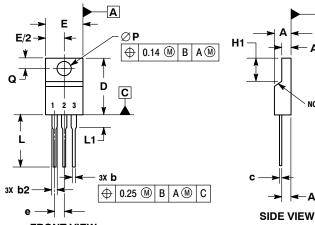
ISSUE F

A1

NOTE 3

A2

B SEATING PLANE

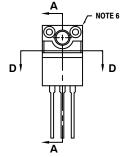


- NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS. 3. CONTOUR UNCONTROLLED IN THIS AREA. 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH AND GATE PROTRUSIONS. MOLD FLASH AND GATE PROTRUSIONS NOT TO EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE TO BE MEASURED AT OUTERMOST EXTREME OF THE PLASTIC BODY. 5. DIMENSION D2 DOES NOT INCLUDE DAMBAR PROTRUSION. LEAD WIDTH INCLUDING PROTRUSION SHALL NOT EXCEED 2.00. 6. CONTOURS AND FEATURES OF THE MOLEDE PACKAGE BODY MAY VARY WITHIN THE ENVELOP DEFINED BY DIMENSIONS A1 AND H1 FOR MANUFACTURING PURPOSES.

	MILLIMETERS		
DIM	MIN MAX		
Α	4.30	4.70	
A1	2.50	2.90	
A2	2.50	2.90	
b	0.54	0.84	
b2	1.10	1.40	
C	0.49	0.79	
D	14.70	15.30	
Е	9.70	10.30	
е	2.54 BSC		
H1	6.60	7.10	
L	12.50	14.73	
L1		2.80	
Ρ	3.00	3.40	
Q	2.80	3.20	

FRONT VIEW





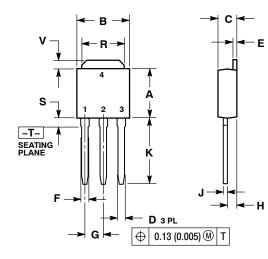
NOTE 6 **SECTION A-A**

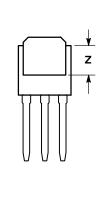
ALTERNATE CONSTRUCTION



PACKAGE DIMENSIONS

IPAK CASE 369D ISSUE C





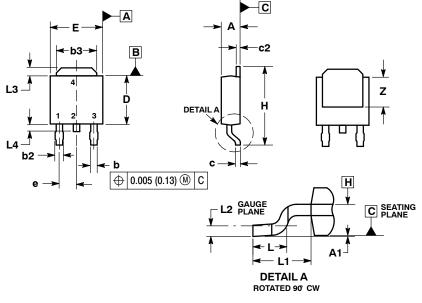
NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INC	NCHES MILLIMETER			
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090	BSC	2.29 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
κ	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
V	0.035	0.050	0.89	1.27	
Ζ	0.155		3.93		

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE) CASE 369AA

ISSUE B

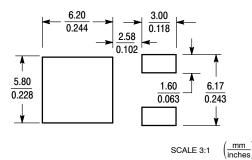


NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994. CONTROLLING DIMENSION: INCHES. 2
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
- LIGHTONSONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29	BSC	
н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108	REF	2.74 REF		
L2	0.020	BSC	0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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